Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/931,389	M.N. ET AL.
Examiner	Art Unit
Lo Nauven	2174

	SEARCHED		
Class	Subclass	Date	Examiner
715	764	7/6/2006	LVN
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	B, USPAT: /764	7/6/2006	LVN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
consulted w/Ba Huynh	7/6/2006	LVN		
US-PGPUB, USPAT: 764,766,767,794,806	7/6/2006	LVN		